

# FMH23N50ES

FUJI POWER MOSFET

## Super FAP-E<sup>3S</sup> series

## N-CHANNEL SILICON POWER MOSFET

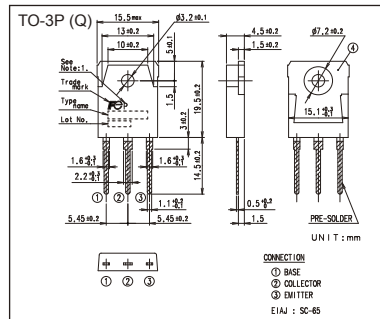
### ■ Features

- Maintains both low power loss and low noise
- Lower  $R_{DS(on)}$  characteristic
- More controllable switching  $dv/dt$  by gate resistance
- Smaller  $V_{GS}$  ringing waveform during switching
- Narrow band of the gate threshold voltage ( $4.2 \pm 0.5V$ )
- High avalanche durability

### ■ Applications

- Switching regulators
- UPS (Uninterruptible Power Supply)
- DC-DC converters

### ■ Outline Drawings [mm]



### ■ Equivalent circuit schematic



### ■ Maximum Ratings and Characteristics

#### ● Absolute Maximum Ratings at $T_c=25^\circ C$ (unless otherwise specified)

| Description   | Symbol    | Characteristics | Unit        | Remarks          |
|---|-----------|-----------------|-------------|------------------|
| Drain-Source Voltage                                    | $V_{DS}$  | 500             | V           |                  |
|   | $V_{DSX}$ | 500             | V           | $V_{GS} = -30V$  |
| Continuous Drain Current                                | $I_D$     | $\pm 23$        | A           |                  |
| Pulsed Drain Current                                    | $I_{DP}$  | $\pm 92$        | A           |                  |
| Gate-Source Voltage                                     | $V_{GS}$  | $\pm 30$        | V           |                  |
| Repetitive and Non-Repetitive Maximum Avalanche Current | $I_{AR}$  | 23              | A           | Note*1           |
| Non-Repetitive Maximum Avalanche Energy                 | $E_{AS}$  | 767.3           | mJ          | Note*2           |
| Repetitive Maximum Avalanche Energy                     | $E_{AR}$  | 31.5            | mJ          | Note*3           |
| Peak Diode Recovery $dV/dt$                             | $dV/dt$   | 5.4             | kV/ $\mu s$ | Note*4           |
| Peak Diode Recovery $-di/dt$                            | $-di/dt$  | 100             | A/ $\mu s$  | Note*5           |
| Maximum Power Dissipation                               | $P_D$     | 2.50            | W           | $T_a=25^\circ C$ |
|   |           | 315             |             | $T_c=25^\circ C$ |
| Operating and Storage Temperature range                 | $T_{ch}$  | 150             | $^\circ C$  |                  |
|   | $T_{slg}$ | -55 to + 150    | $^\circ C$  |                  |

#### ● Electrical Characteristics at $T_c=25^\circ C$ (unless otherwise specified)

| Description                      | Symbol       | Conditions                              | min. | typ.  | max.  | Unit     |
|----------------------------------|--------------|---|------|-------|-------|----------|
| Drain-Source Breakdown Voltage   | $BV_{DSS}$   | $I_D=250\mu A, V_{GS}=0V$               | 500  | -     | -     | V        |
| Gate Threshold Voltage           | $V_{GS(th)}$ | $I_D=250\mu A, V_{DS}=V_{GS}$           | 3.7  | 4.2   | 4.7   | V        |
| Zero Gate Voltage Drain Current  | $I_{DSS}$    | $V_{DS}=500V, V_{GS}=0V$                | -    | -     | 25    | $\mu A$  |
|                                  |              | $V_{DS}=400V, V_{GS}=0V$                | -    | -     | 250   |          |
| Gate-Source Leakage Current      | $I_{GSS}$    | $V_{GS}=\pm 30V, V_{DS}=0V$             | -    | 10    | 100   | nA       |
| Drain-Source On-State Resistance | $R_{DS(on)}$ | $I_D=11.5A, V_{GS}=10V$                 | -    | 0.209 | 0.245 | $\Omega$ |
| Forward Transconductance         | $g_{fs}$     | $I_D=11.5A, V_{GS}=25V$                 | 8.5  | 17    | -     | S        |
| Input Capacitance                | $C_{iss}$    | $V_{DS}=25V$                            | -    | 2700  | 4050  | pF       |
| Output Capacitance               | $C_{oss}$    | $V_{GS}=0V$                             | -    | 330   | 495   |          |
| Reverse Transfer Capacitance     | $C_{rss}$    | $f=1MHz$                                | -    | 20    | 30    |          |
| Turn-On Time                     | $t_{d(on)}$  | $V_{cc}=300V$                           | -    | 42    | 63    | ns       |
|                                  | $t_r$        | $V_{GS}=10V$                            | -    | 36    | 54    |          |
| Turn-Off Time                    | $t_{d(off)}$ | $I_D=11.5A$                             | -    | 94    | 141   |          |
|                                  | $t_f$        | $R_{GS}=10\Omega$                       | -    | 17    | 25.5  |          |
| Total Gate Charge                | $Q_G$        | $V_{cc}=250V$                           | -    | 73    | 109.5 | nC       |
| Gate-Source Charge               | $Q_{GS}$     | $I_D=23A$                               | -    | 24    | 36    |          |
| Gate-Drain Charge                | $Q_{GD}$     | $V_{GS}=10V$                            | -    | 27    | 40.5  |          |
| Gate-Drain Crossover Charge      | $Q_{SW}$     |   | -    | 10    | 15    |          |
| Avalanche Capability             | $I_{AV}$     | $L=1.16mH, T_{ch}=25^\circ C$           | 23   | -     | -     | A        |
| Diode Forward On-Voltage         | $V_{SD}$     | $I_F=23A, V_{GS}=0V, T_{ch}=25^\circ C$ | -    | 0.90  | 1.35  | V        |
| Reverse Recovery Time            | $t_{rr}$     | $I_F=23A, V_{GS}=0V$                    | -    | 0.5   | -     | $\mu s$  |
| Reverse Recovery Charge          | $Q_{rr}$     | $-di/dt=100A/\mu s, T_{ch}=25^\circ C$  | -    | 8.0   | -     | $\mu C$  |

#### ● Thermal Characteristics

| Description        | Symbol         | Test Conditions    | min. | typ. | max. | Unit         |
|--------------------|----------------|--------------------|------|------|------|--------------|
| Thermal resistance | $R_{th(ch-c)}$ | Channel to Case    |      |      | 0.40 | $^\circ C/W$ |
|                    | $R_{th(ch-a)}$ | Channel to Ambient |      |      | 50.0 | $^\circ C/W$ |

Note \*1 :  $T_{ch} \leq 150^\circ C$ .

Note \*2 : Stating  $T_{ch}=25^\circ C, I_{AS}=10A, L=14.1mH, V_{cc}=50V, R_G=50\Omega$ .

$E_{AS}$  limited by maximum channel temperature and avalanche current.  
See to 'Avalanche Energy' graph.

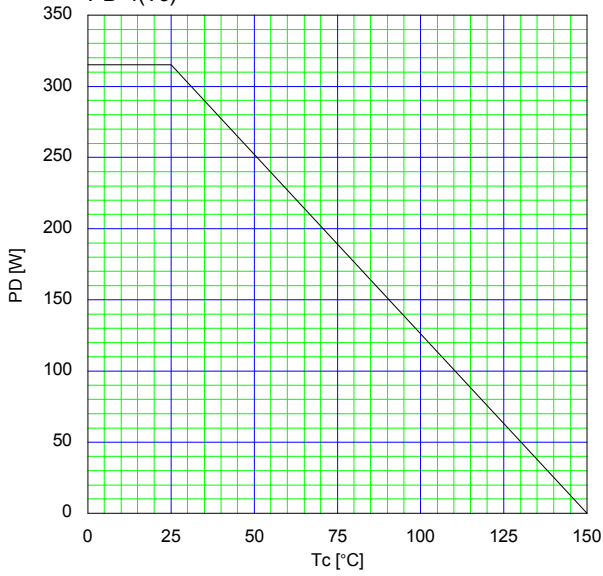
Note \*3 : Repetitive rating : Pulse width limited by maximum channel temperature.

See to the 'Transient Thermal Impedance' graph.

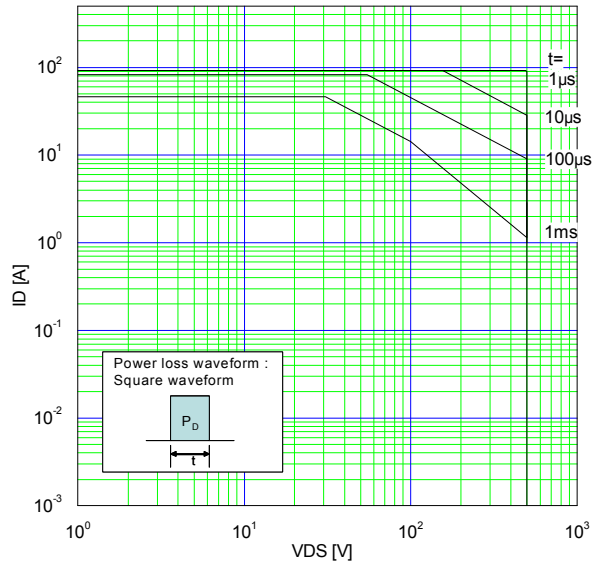
Note \*4 :  $I_F \leq I_D, -di/dt=100A/\mu s, V_{cc} \leq BV_{DSS}, T_{ch} \leq 150^\circ C$ .

Note \*5 :  $I_F \leq I_D, dv/dt=5.4kV/\mu s, V_{cc} \leq BV_{DSS}, T_{ch} \leq 150^\circ C$ .

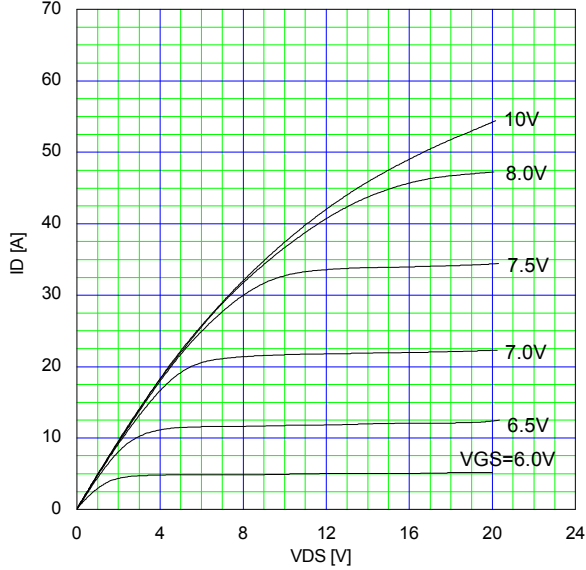
Allowable Power Dissipation  
 $P_D = f(T_c)$



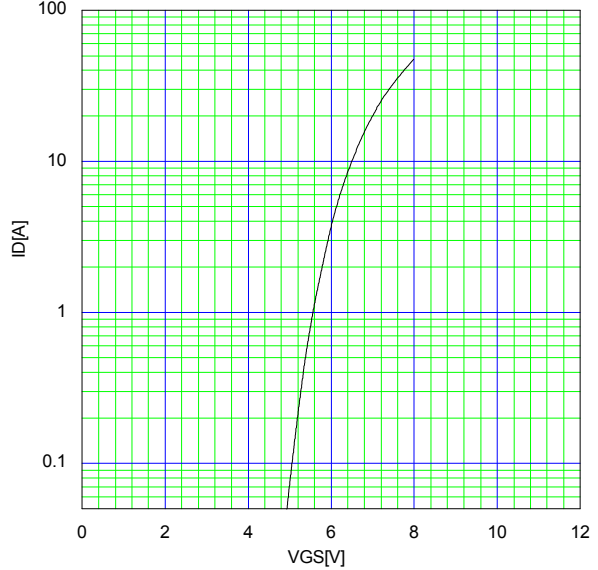
Safe Operating Area  
 $I_D = f(V_{DS})$ : Duty=0 (Single pulse),  $T_c = 25^\circ\text{C}$



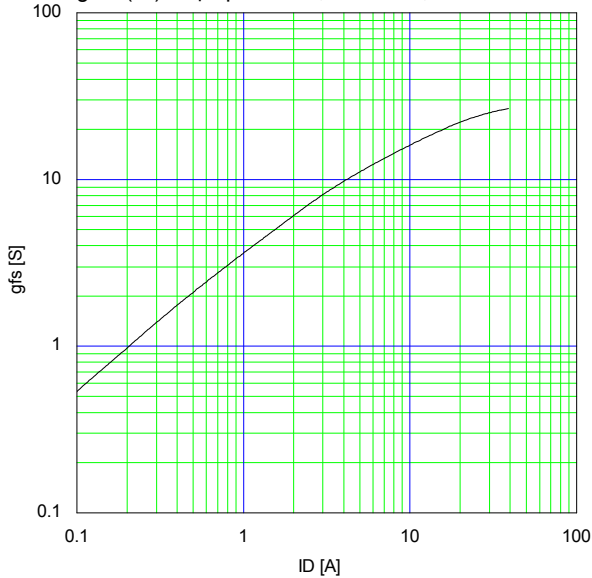
Typical Output Characteristics  
 $I_D = f(V_{DS})$ : 80 µs pulse test,  $T_{ch} = 25^\circ\text{C}$



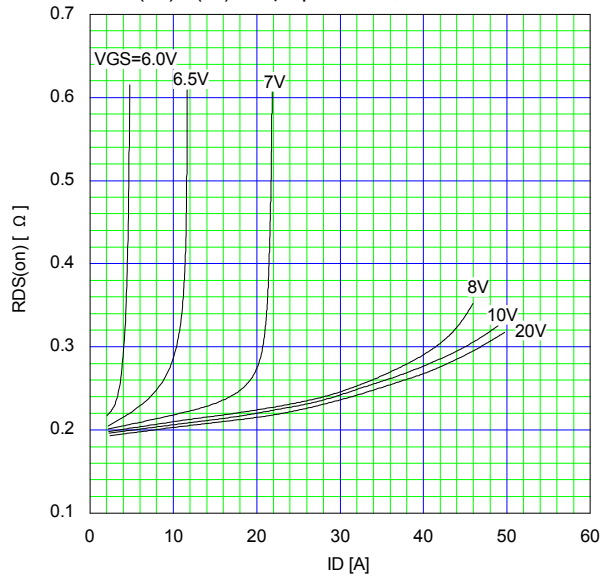
Typical Transfer Characteristic  
 $I_D = f(V_{GS})$ : 80 µs pulse test,  $V_{DS} = 25\text{V}$ ,  $T_{ch} = 25^\circ\text{C}$



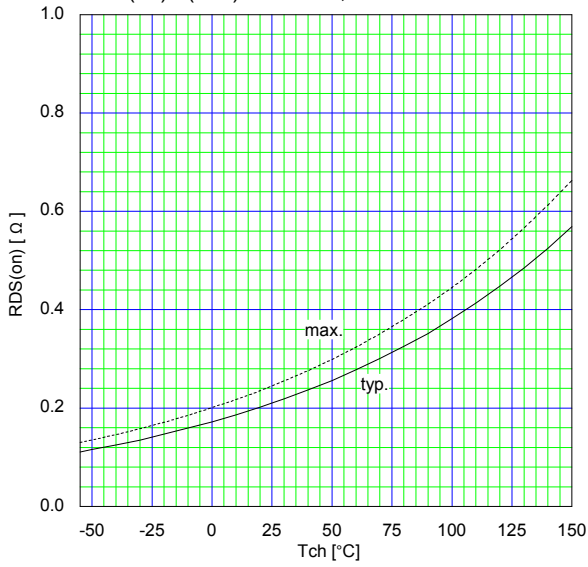
Typical Transconductance  
 $g_{fs} = f(I_D)$ : 80 µs pulse test,  $V_{DS} = 25\text{V}$ ,  $T_{ch} = 25^\circ\text{C}$



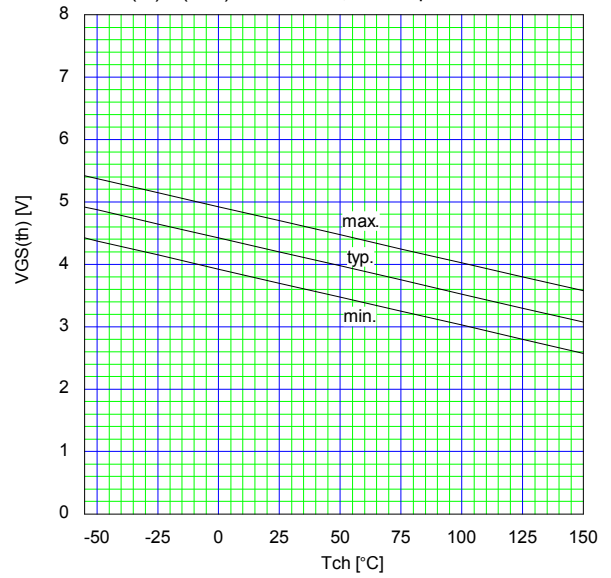
Typical Drain-Source on-state Resistance  
 $R_{DS(on)} = f(I_D)$ : 80 µs pulse test,  $T_{ch} = 25^\circ\text{C}$



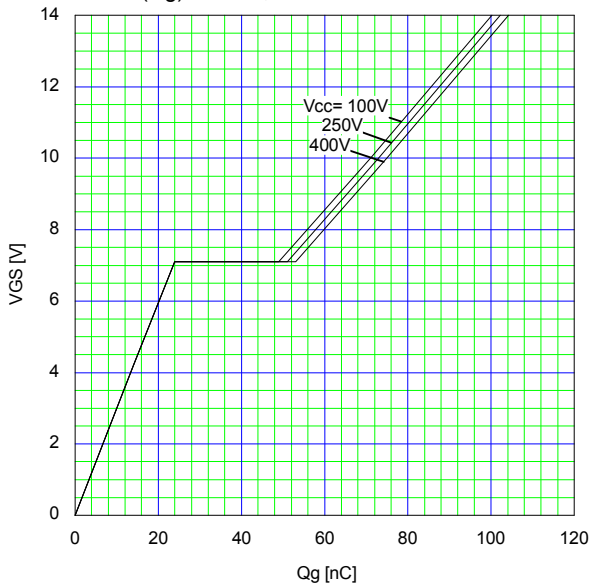
Drain-Source On-state Resistance  
 $R_{DS(on)}=f(T_{ch}):I_D=11.5A, V_{GS}=10V$



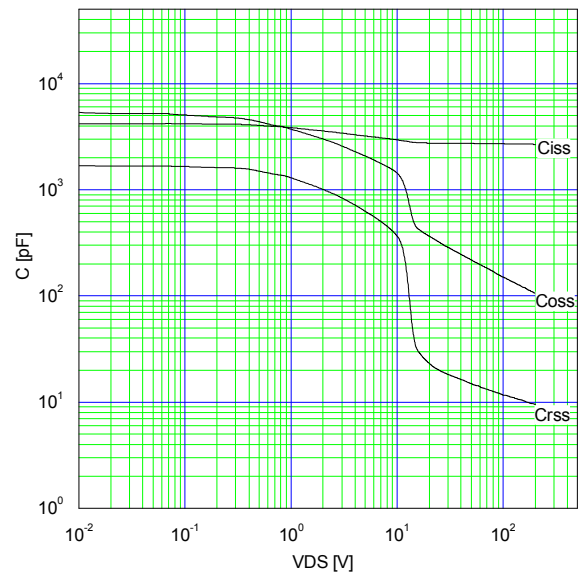
Gate Threshold Voltage vs. T<sub>ch</sub>  
 $V_{GS(th)}=f(T_{ch}):V_{DS}=V_{GS}, I_D=250\mu A$



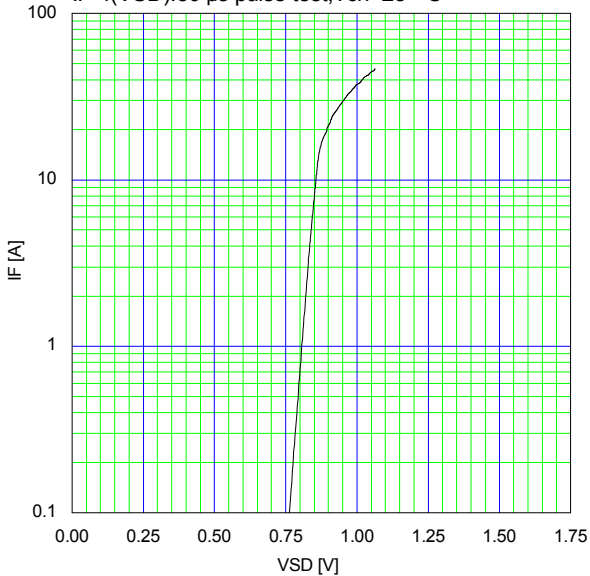
Typical Gate Charge Characteristics  
 $V_{GS}=f(Q_g):I_D=23A, T_{ch}=25\text{ }^\circ\text{C}$



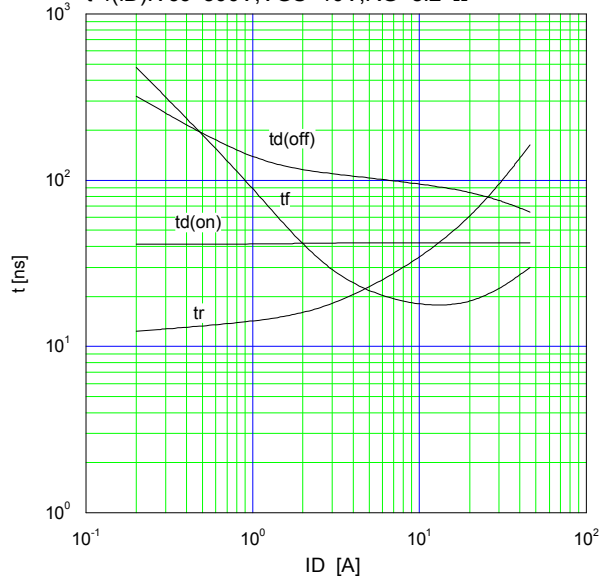
Typical Capacitance  
 $C=f(V_{DS}):V_{GS}=0V, f=1MHz$



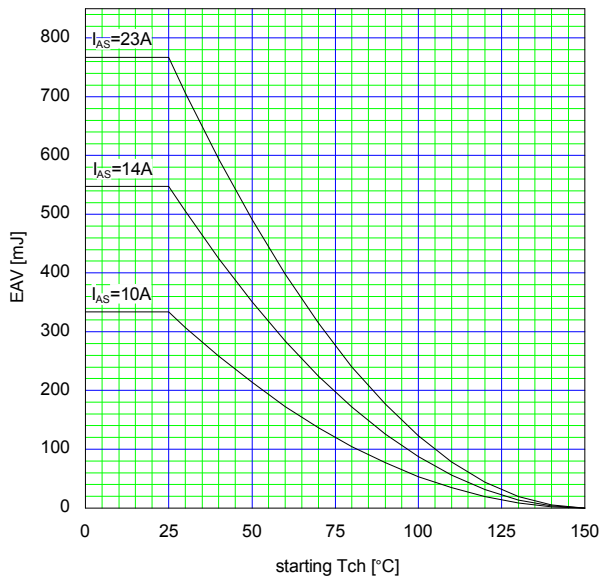
Typical Forward Characteristics of Reverse Diode  
 $I_F=f(V_{SD}):80\text{ }\mu s\text{ pulse test}, T_{ch}=25\text{ }^\circ\text{C}$



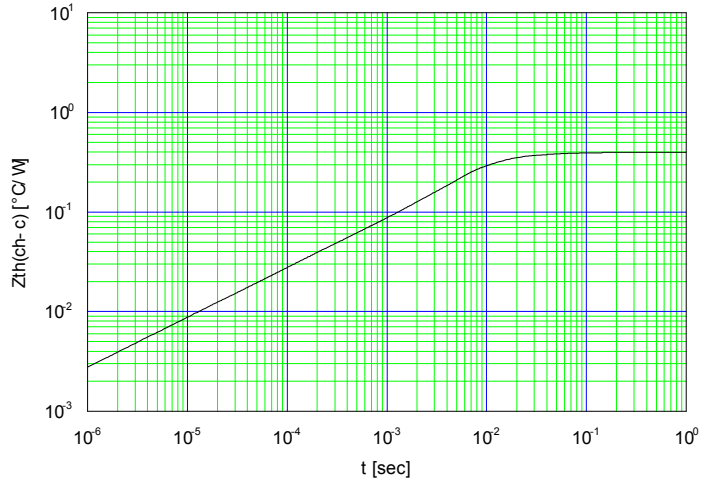
Typical Switching Characteristics vs. I<sub>D</sub>  
 $t=f(I_D):V_{cc}=300V, V_{GS}=10V, R_G=8.2\text{ }\Omega$



Maximum Avalanche Energy vs. starting Tch  
 $E(AV)=f(\text{starting Tch}):V_{CC}=50V, I(AV)\leq 23A$



Maximum Transient Thermal Impedance  
 $Z_{th(ch-c)}=f(t):D=0$



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